TOSHIBA VARIABLE CAPACITANCE DIODE SILICON EPITAXIAL PLANAR TYPE

1 S V 2 9 3

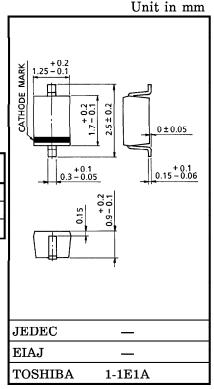
VCO FOR UHF BAND RADIO

Ultra Low Series Resistance : $r_S = 0.26\Omega$ (Typ.)

Useful for Small Size Set

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Reverse Voltage	v_{R}	10	V
Junction Temperature	$T_{ m j}$	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C



Weight: 0.004g

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Reverse Voltage	$V_{\mathbf{R}}$	$I_R=1\mu A$	10	_	_	V
Reverse Current	$I_{\mathbf{R}}$	$V_R=10V$	_	-	3	nA
Capacitance	c_{1V}	$V_R=1V$, f=1MHz	18.0	_	20.0	pF
Capacitance	$\mathrm{c_{4V}}$	$V_R=4V$, f=1MHz	10.1	_	11.6	pF
Capacitance Ratio	C_{1V}/C_{4V}	_	1.55	_	_	_
Series Resistance	r_s	V_R =1V, f=470MHz	_	0.26	0.4	Ω

Marking



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